Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/676,430	ADL-TABATABAI ET AL.	
Examiner	Art Unit	
Chun-Kuan (Mike) Lee	2181	_

SEARCHED					
Class	Subclass	Date	Examiner		
710	54	3/20/2007	CHUN- KUAN Lea		
710	68	3/20/2007	V		
					
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
					
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
·	DATE	EXMR		
(EAST) US-PGPUB; USPAT; USOCR; EPO; JPO; DERWENT; IBM_TDB Inventor search on PALM and eDAN	3/20/2007	CHUN- KUAN Lee		
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